

Search Notes

Application/Control No.

10/655,168

Examiner

Abdelmoniem Elamin

Applicant(s)/Patent under
Reexamination

CHEN, CHIH-WEI

Art Unit

2116

SEARCHED

| Class | Subclass | Date | Examiner |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| WEST | 12/28/2006 | AIE |
| WEST | 12/18/2006 | AIE |
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